Synthesis of porous LSM films on dense YSZ substrates for use in SOFC

D.P. Tarragó¹, C.F. Malfatti¹ and V.C. Sousa¹
¹ School of Engineering
Federal University of Rio Grande do Sul
Porto Alegre – Rio Grande do Sul, CEP: 91509-900 (Brazil)
Phone:+5551 3308 9485, e-mail: diego.tarrago@ufrgs.br, celia.malfatti@ufrgs.br, vania.sousa@ufrgs.br

Abstract.

Ceramic thin films are of great importance in the development and fabrication of devices such as SOFC. The porous microstructure of the electrodes is crucial for the overall performance of the SOFC and it is quite influenced by the fabrication process. In this sense, LSM films were obtained over 0.25 µm rough YSZ dense substrates heated at 650°C, using a salts solution and an airbrush. By XRD patterns the LSM perovskite phase was identified in both samples. The obtained films showed very high porosity with great pore size distribution. The LSM films exhibit grains with size around 60 nm in average. A more continuous film, practically without cracks, was obtained depositing 2 mL of the solution. The presence of microstructural defects in the film obtained with 1.5 mL of solution increased the cathode polarization compared with the one obtained with 2.0 mL of solution.

Key words

Thin films, strontium doped lanthanum manganite, solid oxide fuel cell.

1. Introduction

The development of inexpensive methods to obtain porous and thin ceramic films can reduce the cost of several technological products, including energy generation devices such as SOFC. Strontium doped lanthanum manganite (LSM) is the most commonly used material as cathode of the SOFC and for this application the LSM must deposited over an electrolyte or an interconnector as a thin and porous film [1,2].

In order to enhance the SOFC cathode performance the final microstructure must favour the gas flow through an interconnected porosity net and also possess high specific surface area to increase the amount of reactive sites, improving the catalysis of $O_2$ reduction, which is a limiting factor in the overall reaction of the SOFC [3,4]. In this sense, by promoting an adequate gas flow through a high surface net of pores the performance of the SOFC device can be increased. Besides, a better catalytic activity is expected for nanostructured catalysts [5,6].

In this study we intended to obtain nanostructured porous and thin LSM films over heated yttria stabilized zirconia (YSZ) dense substrates using a metal salts solution and an airbrush.

2. Experimental

2.1 YSZ substrates

The preparation of the YSZ substrates were carried out by mixing the YSZ powder (Sigma-Aldrich, 99.9%) with 2.5 wt.% of an aqueous solution containing polyvinyl alcohol (PVA) binder at 10 wt.%, for 1 h in a ball mill. After drying at 120°C, the powder was uniaxially pressed at 220 MPa in a 12 mm diameter mould and sintered at 1450°C for 1.5 h. A complete route for the preparation of substrates is shown in Fig.1.

The apparent porosity of the sintered substrates was determined by the Archimedes method and a CETR PRO500 3D profilometer was used to analyse the surface profile and roughness (Ra). Also, the YSZ substrates were observed in a Jeol JSM-6060 scanning electron microscope (SEM) and an X-ray diffraction (XRD) pattern was generated in a Philips equipment.

Fig. 1: Preparation route of the YSZ substrates.
2.2 LSM films

For the deposition of the films La(NO₃)₃·6H₂O (lanthanum nitrate, 99%), Sr(NO₃)₂ (strontium nitrate, 99%) and Mn(NO₃)₃·4H₂O (manganese nitrate, 99%), all from Vetec-Brazil, were added to an aqueous solution and dissolved. The calculation of salts’ amounts aimed the obtaining of La₉Sr₁MnO₃. The solution was airbrushed in YSZ substrates heated at 650°C in volumes of 1.5 and 2.0 ml. After the deposition, the films were calcined at 850°C for 1 h.

The phase formed in the obtained films was determined by XRD and their microstructures were observed in SEM micrographs. Finally, electrochemical impedance spectroscopy (EIS) measurements were done in air from 500 to 850°C and recorded with an Autolab FRA in a frequency range of 0.1 to 10⁶ Hz and an AC signal of 50 mV. The spectra were acquired during the samples’ heating with a rate of 5°C/min and 15 minute stabilization. A flowchart of the fabrication of the thin films is in Fig. 2, including the nomenclature of the samples, according to the amount of solution used to fabricate the film.

![Flowchart](image)

3. Results and Discussion

3.1 Characterization of YSZ substrates

The YSZ substrates reached a densification of 97.6% (±1.6%). The 3D surface profile generated with the profilometer is shown in Fig 3. The substrates were as rough as 0.25 µm. For the deposition of thin films a surface with certain roughness helps on the mechanical anchoring of the coating, improving the film-to-substrate adhesion strength.

![SEM micrograph](image)

3.2 Characterization of LSM films

Over the surface with the characteristics observed before the LSM films were deposited. The Fig. 5 shows a YSZ substrate before the deposition (left) and a YSZ substrate coated with the LSM film after calcination (right).

![Uncoated and coated substrate](image)

In Fig. 6 are shown the generated XRD patterns. It is possible to determine the formation of the LSM perovskite phase (ICDD nº 00-051-0409) on both samples, as identified by the markers (● and Δ).
Also, peaks of the YSZ substrate (ICDD n° 00-048-0224) are observed, they can be appearing because of the films’ porosity or due to the presence of cracks and discontinuities in the coatings. Nevertheless, the defined peaks of the LSM rhombohedral perovskite phase indicate a well crystalized phase.

In the lower magnification SEM micrographs on Fig. 7 it is possible to observe a porous microstructure. They allow us to infer about the continuity of the films and the presence of cracks, as seen in the film F1 (top). In F2 it seems that there are no cracks and also this film is more continuous, judging by the observation of its surface. The continuity of film F2 may explain the more relatively intense peaks in this sample’s XRD pattern.

When observed in medium magnification (Fig. 8), the presence of pores is better distinguished. The larger ones have a diameter of approximately 2 µm and the pore size distribution appears to be more effective in F2 (bottom). In this film it can also be observed that, besides these larger pores, the microstructure is formed by several other pores within a great range of size distribution.

In larger magnification, Fig. 9 very small pores are observed, especially in film F2. In this sample, it is possible to see that, in addition to the larger pores, there is a vast nanoscaled interconnected porosity net. At this level, F1 shows a denser microstructure, while F2 has a great amount of pores with very small sizes, below 100 nm. As well, in both samples the grain size is around 100 nm.
The nanostructured catalyst films where analysed by EIS and in Fig. 10 the spectra of both samples at 750°C is shown. The resistance that appear in low frequencies was attributed to the lack of a contact electrode. We can assume that F2 is thicker than F1, because of higher amount of solution used in its fabrication. However, the high frequencies phenomena, attributed to the electrode polarization [8], shows that F2 has smaller polarization resistance.

The circuit associated to the obtained spectra is in Fig. 11, where Rs is the electrolyte resistance. The parallel resistances Rp_1 and Rp_2 together are the total polarization resistance and Rp_3 is the electrode effect. The constant phase element (CPE) was used to help fitting the Nyquist plots.

The presence of cracks in F1 may explain its higher polarization, observed in the EIS curves. Microstructural defects can concur against films thickness to determine total polarization. In other words, a thicker film tend to present higher polarization, but greater amounts of microstructural defects also increase polarization. It is possible then, that F2, although thicker, has less microstructural defects, as observed in SEM micrographs.

4. Conclusion

It was possible to obtain LSM films with adequate microstructure over a YSZ substrate with 0.25 μm. The obtained films showed very high porosity with great pore size distribution. The LSM films exhibit grains with size around 60 nm in average. A more continuous film, practically without cracks, was obtained in F2. The presence of microstructural defects in F1 increased the cathode polarization compared with F2.
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References


